



# Current status of EM Tile CAL

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JLC CAL Meeting @ Tokyo-Univ

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@ Niigata-Univ



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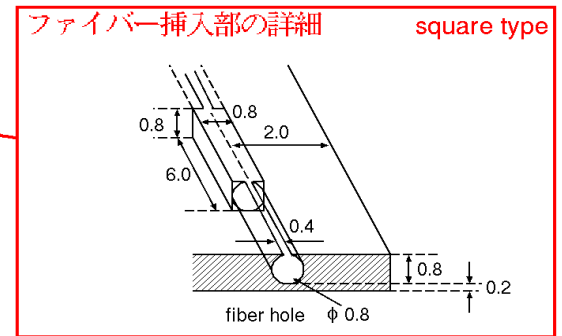
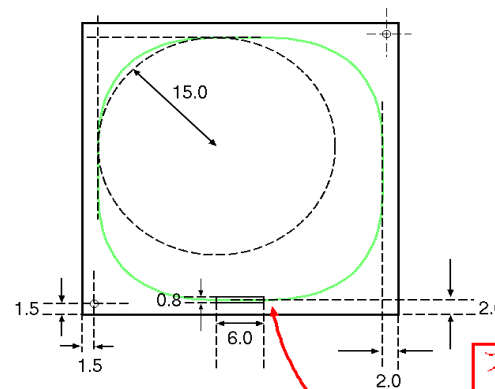
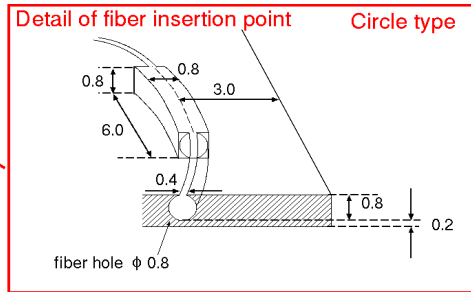
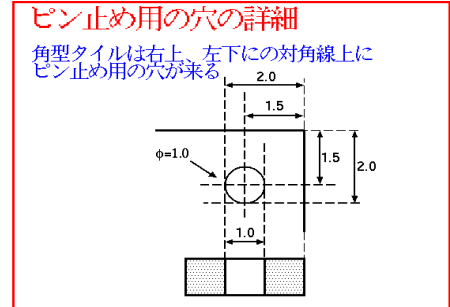
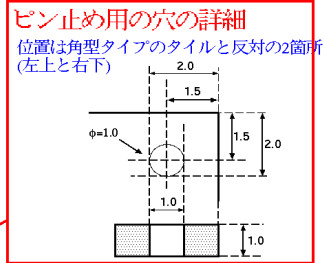
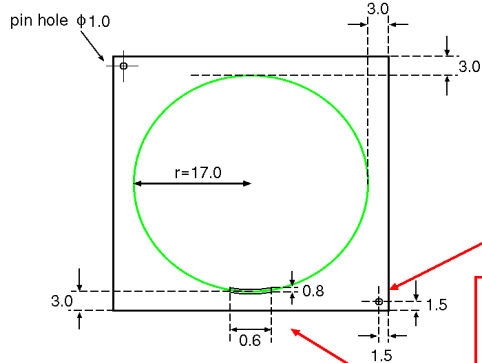


# Beam test preparation

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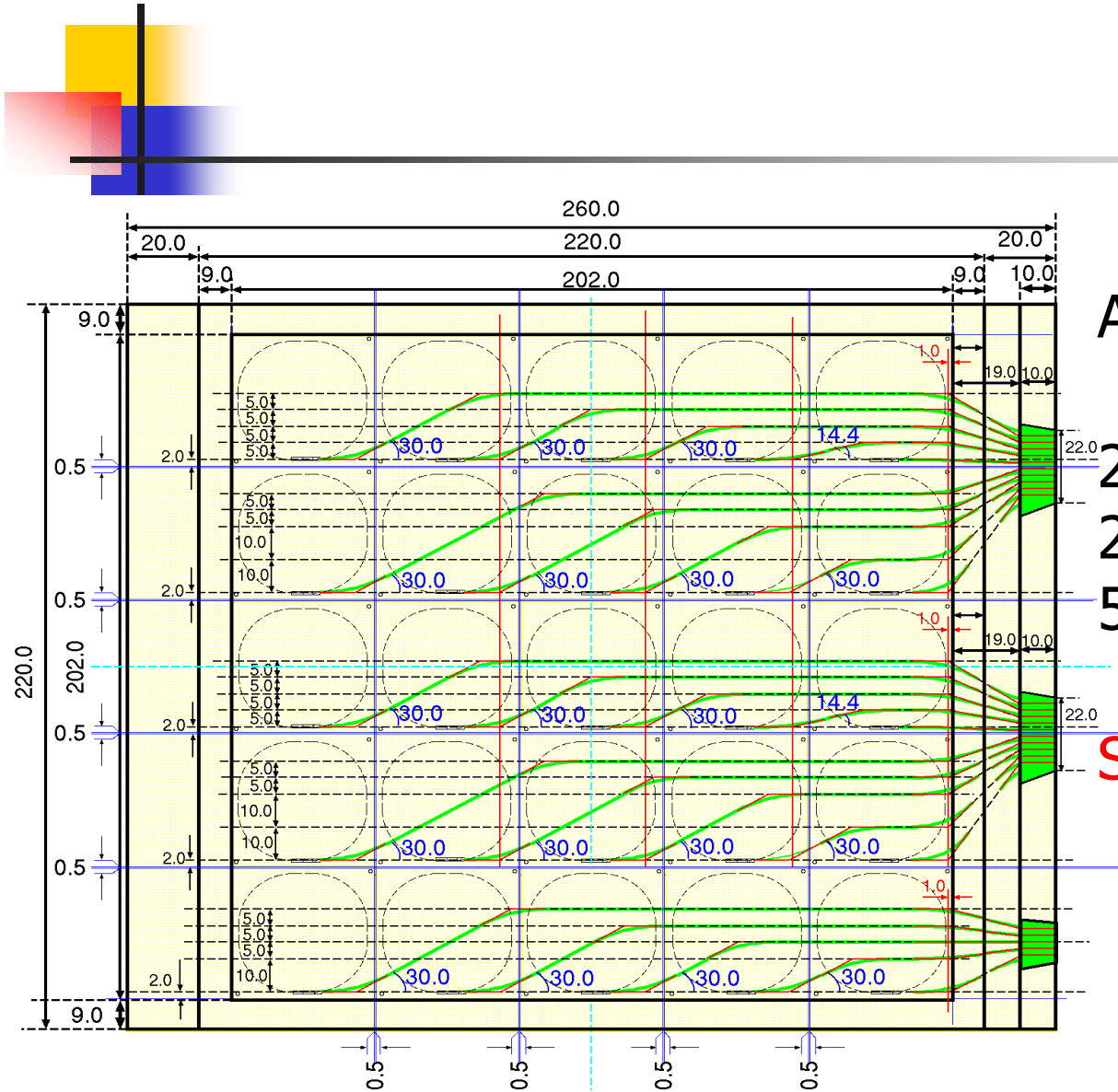
- Design of Niigata Module
  - Two type of tiles (square x125,circle x125)
  - Acryl plate to fix tiles (circle x5+ square x5)
- Order Materials
  - Fiber assembly (Connector+Fiber+Holder)  
Already finished
  - Tiles and Acryl  
Now order samples, then all we need
  - Not finish to order pet film, metal screw

# Design of Niigata Module



**円形タイプの詳細図 (単位 [mm])**  
角型タイプと逆の対角線上にピン穴をつける

**角型タイプの詳細図 (単位 [mm])**  
角型タイプは右上と左下の対角線上にピン穴を付ける (円形タイプとは逆の対角線上)



Acryl plate for square tile

260mm x 210mm  
25 tiles attached  
5 plane we need

Same form for circle tile



# Order Materials

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- Fiber assembly (Connector+Fiber+Holder)
  - Order finished (**we can't get enough holder?**)
- Two types of Tile
  - Scintillator is not enough (Order samples)
- Two types of Acryl plate
  - Order sample molding to Kyoei engineering
- Pet film
- Metal screw (fixed tiles)



# Bench test status

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- One photo electron check
  - One photo electron peak :  $PH = 19.7$
  - We cannot see two P.E. peak or shoulder
- Mapping test
  - Cannot see dependence and large non uniformity  
Why?? Trigger problems?
  - Difference from the previous data taking : use(befor)  
or not use(now) own trigger



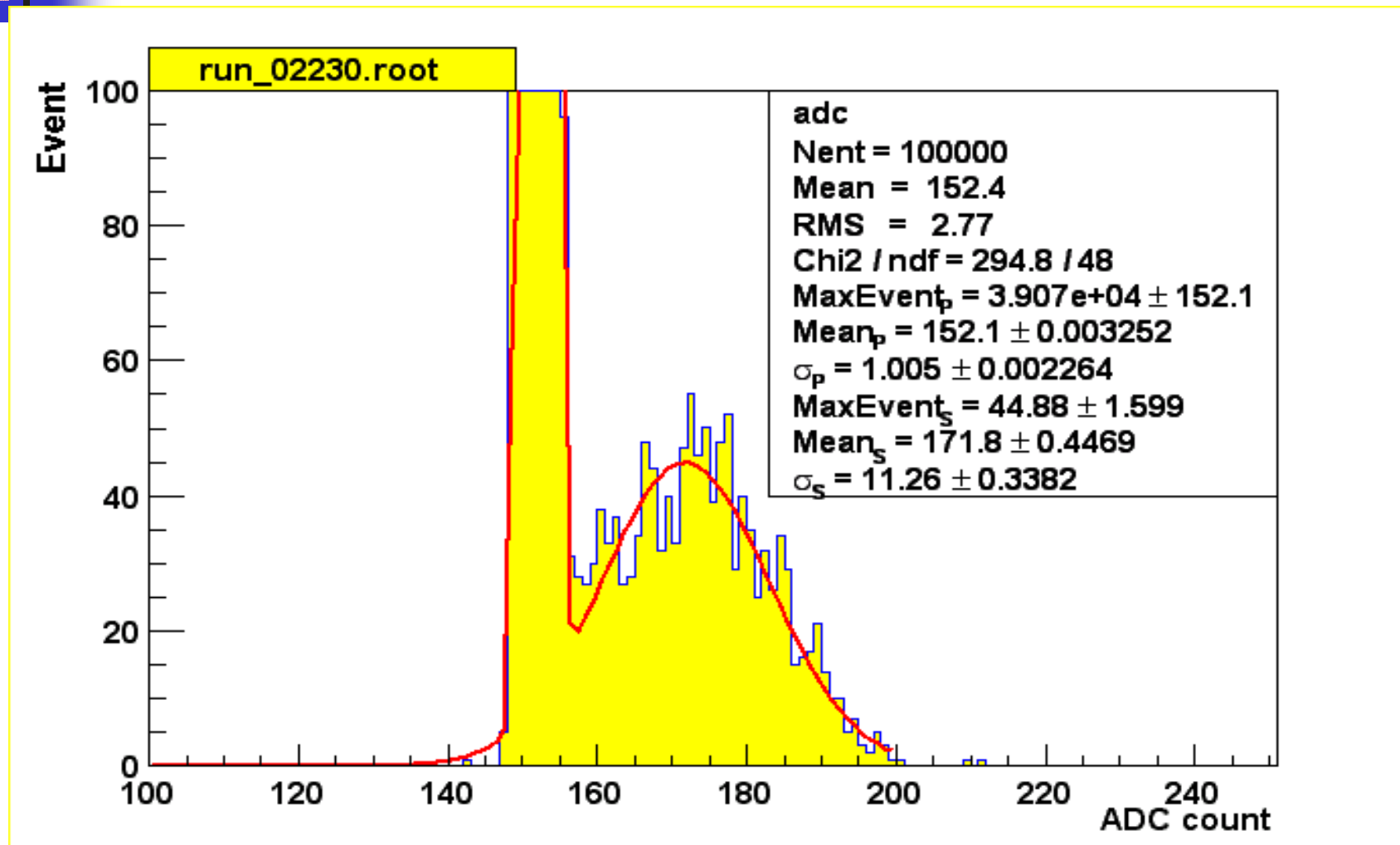
# One photo electron check

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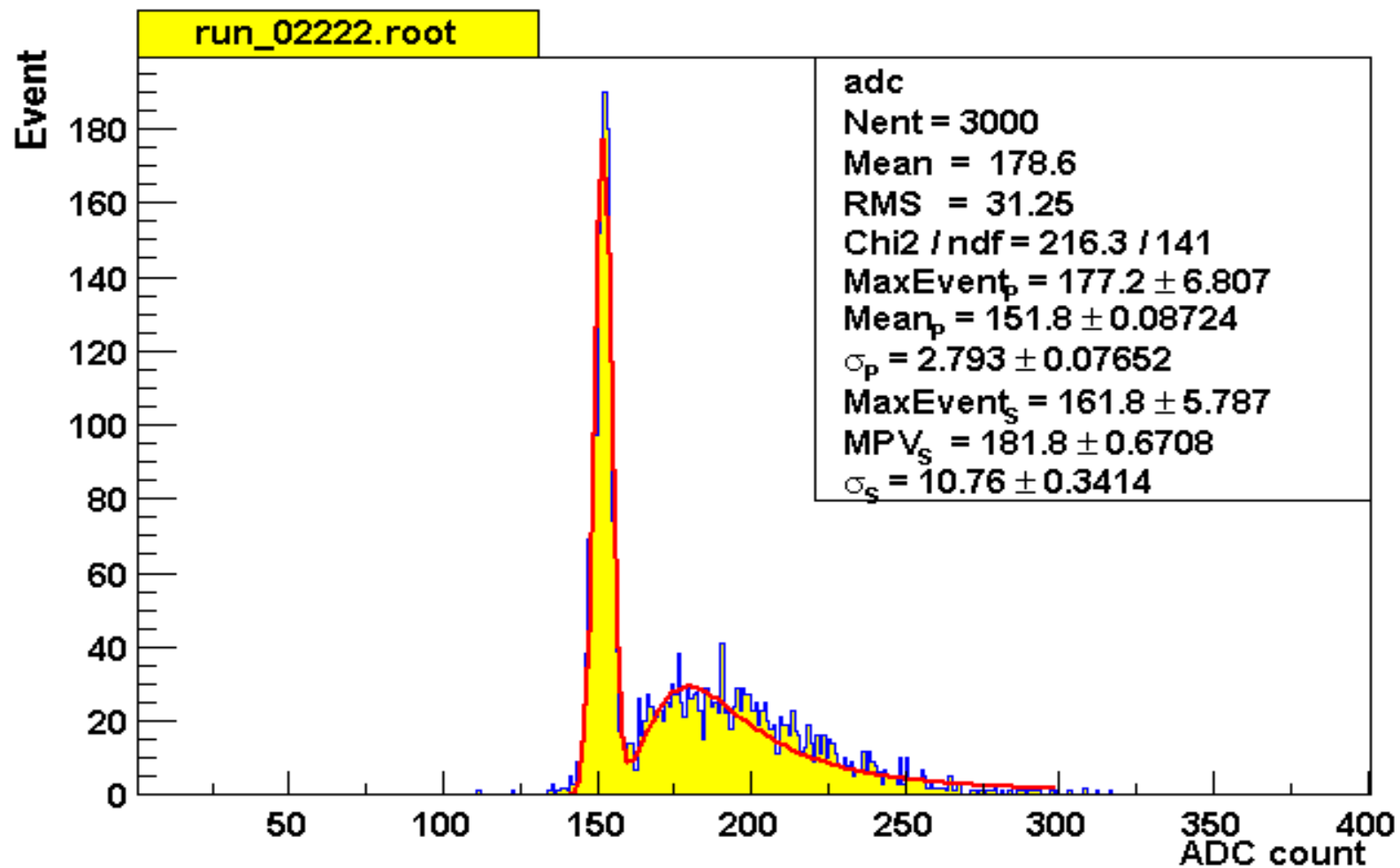
- Use ND filter (Transparency= $10\%+32\%$ )
- Measure one P.E. peak
  - PH<sub>1.P.E.</sub> = 19.7
- Mean value of usual Pulse height
  - PH<sub>mean</sub> = 44.4
- # of P.E.\_mean =  $44.4/19.7=2.2$ 
  - Small value we expected!
- We cannot see two P.E. peak or shoulder



# One P.E. peak figure



# Usual ADC distribution



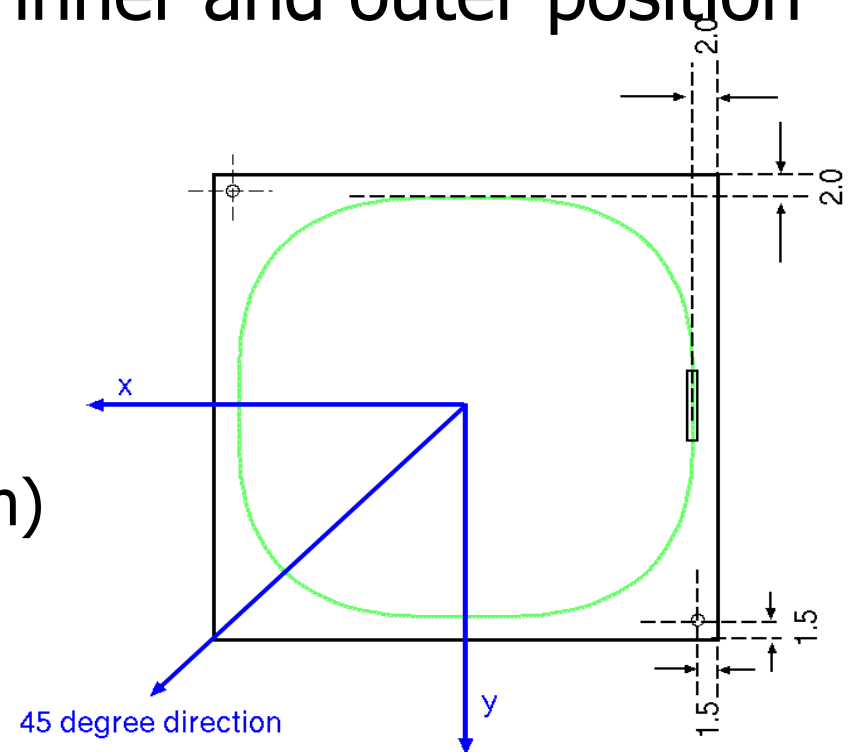
# Mapping test

- Data taking : 2mm step
- Direction : x-axis, y-axis, 45° direction
- Check difference between fiber inner and outer position and corner

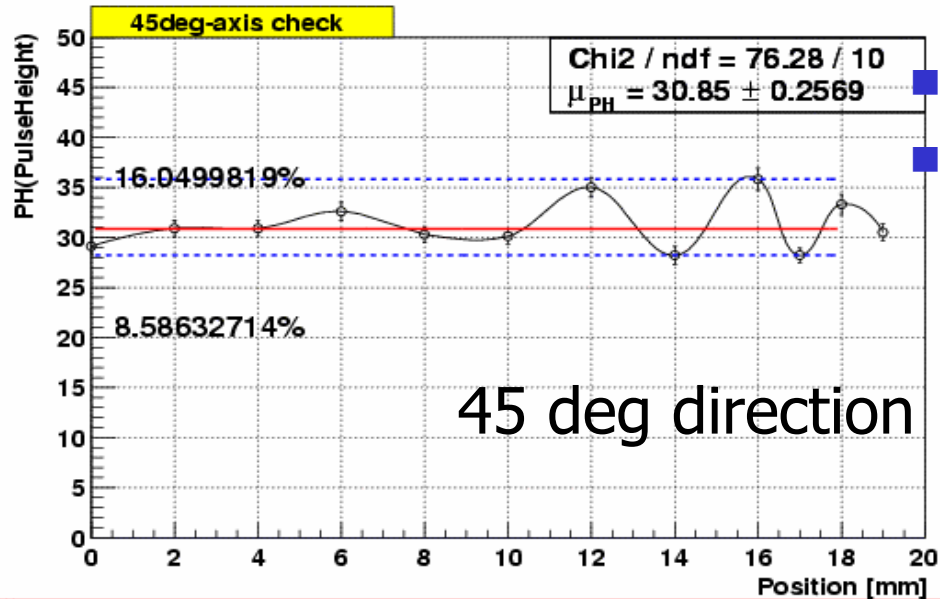
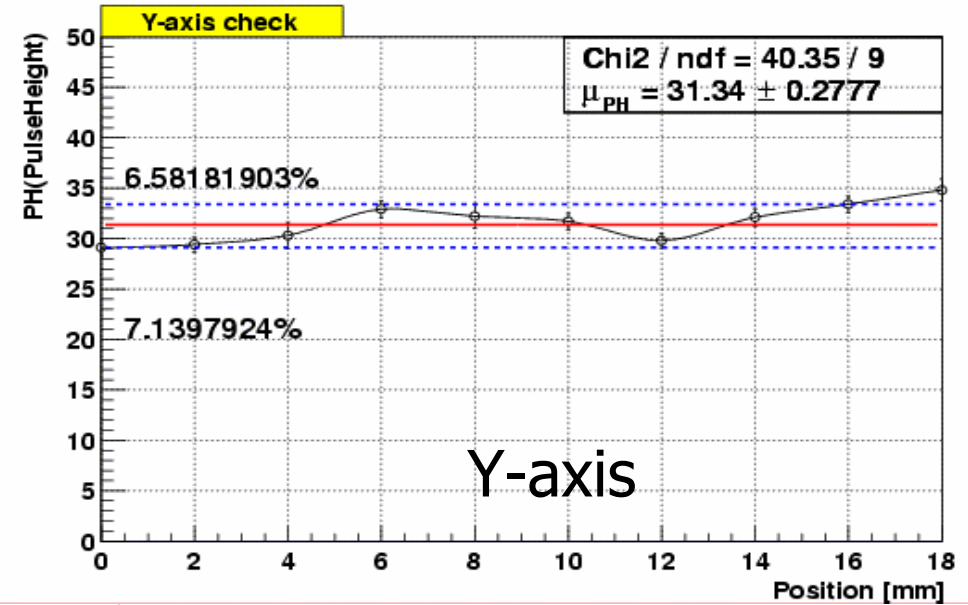
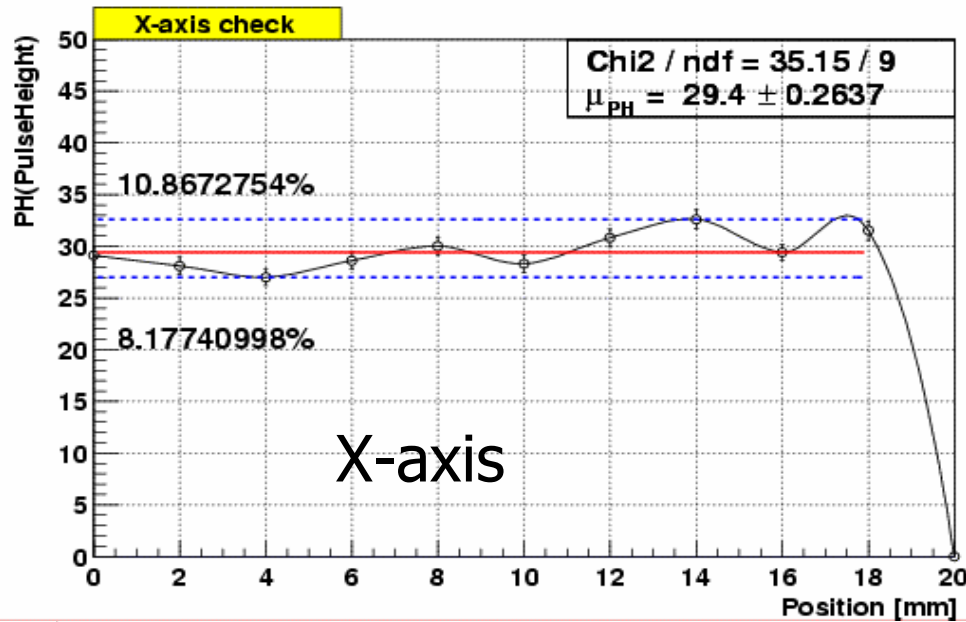
Expected following dependence

Minimum at  $x, y = 18.0\text{mm}$  (fiber position)

Maximum near the fiber position

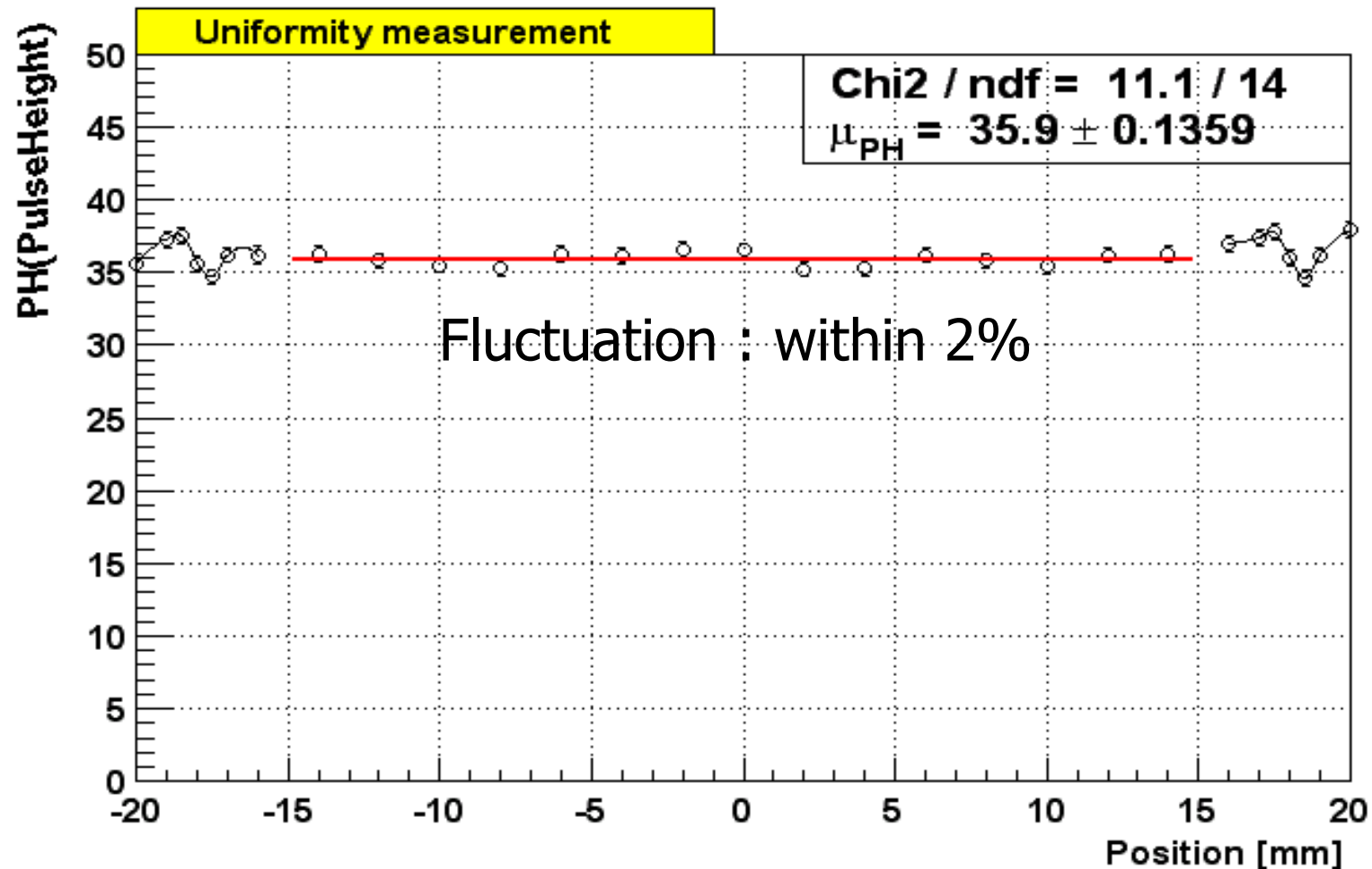


# Results



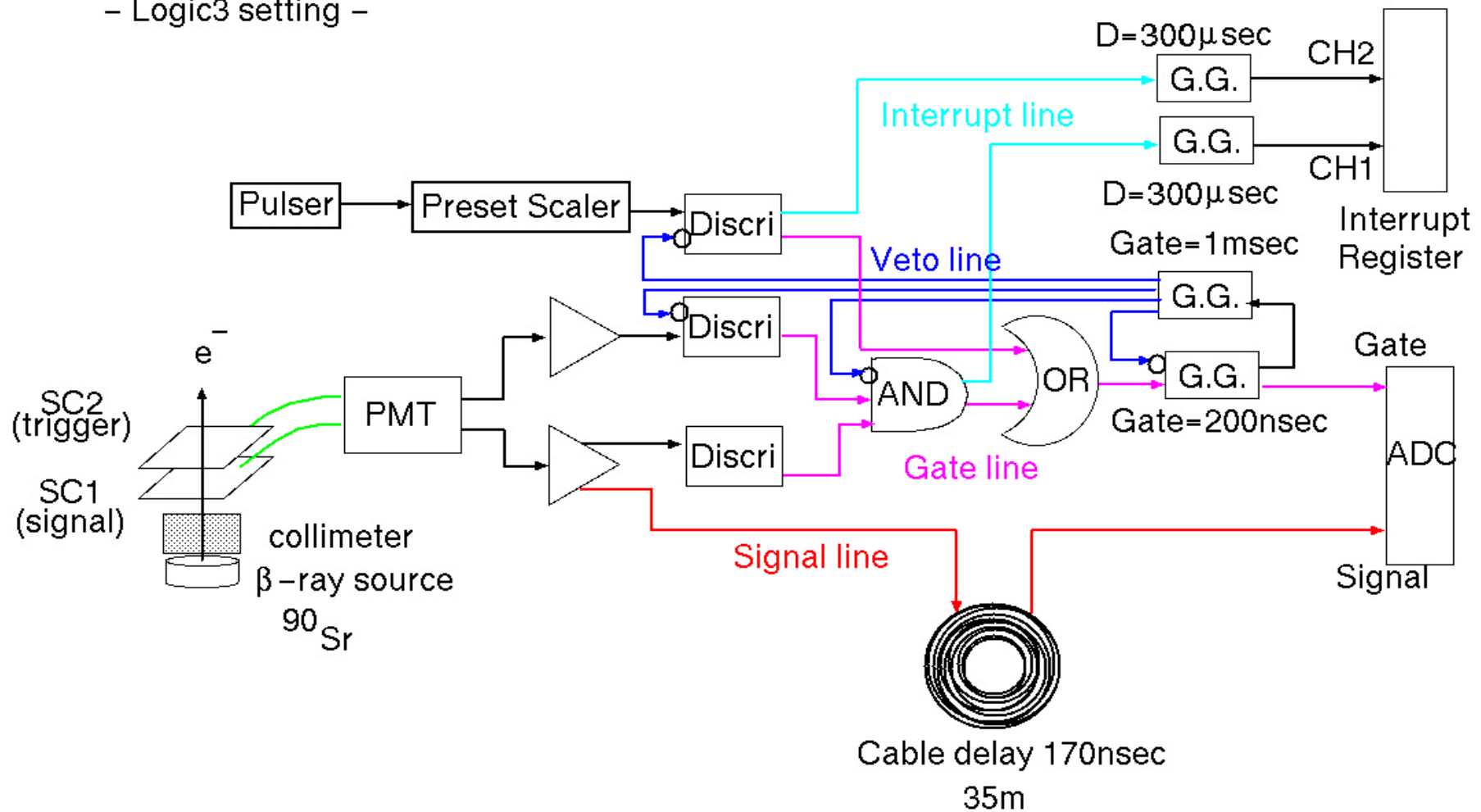
- Cannot see position dependence
- Large none uniformity (compare to previous data)  
 2%    7% ~ 17%  
 only change trigger system

# Previous uniformity checking

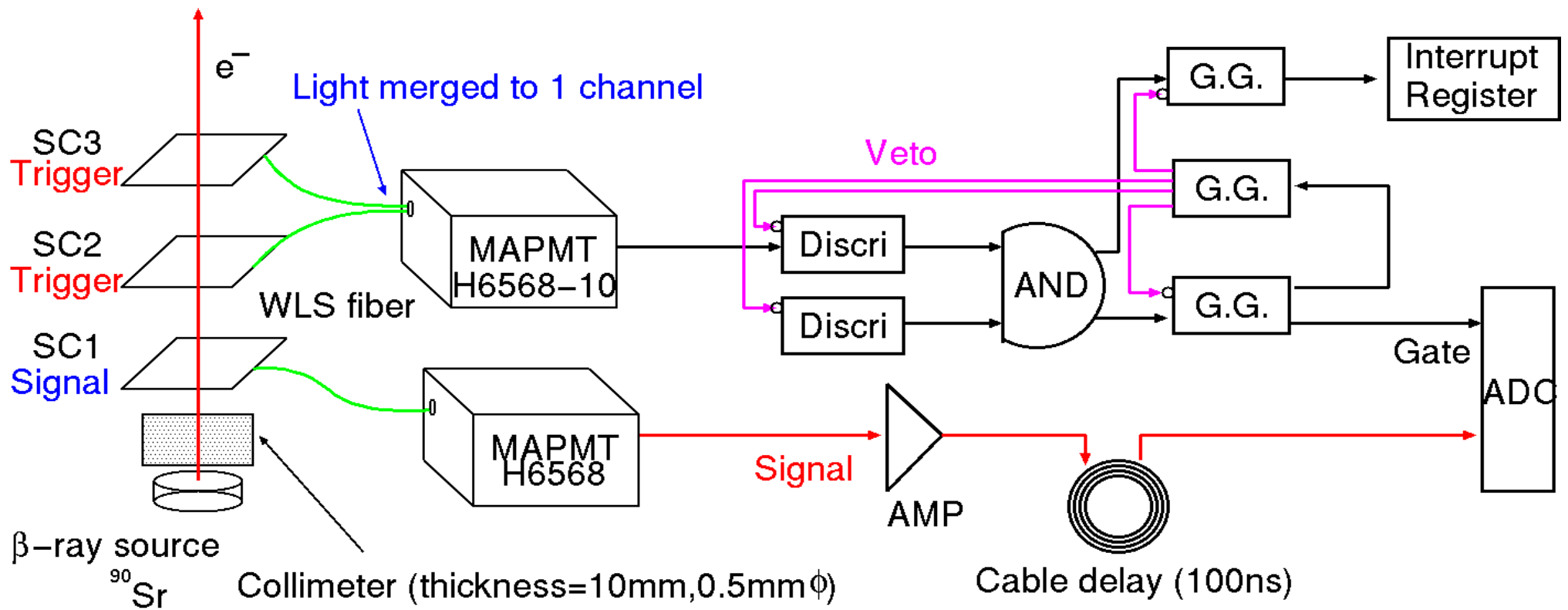


# Previous logic setting

- Logic3 setting -

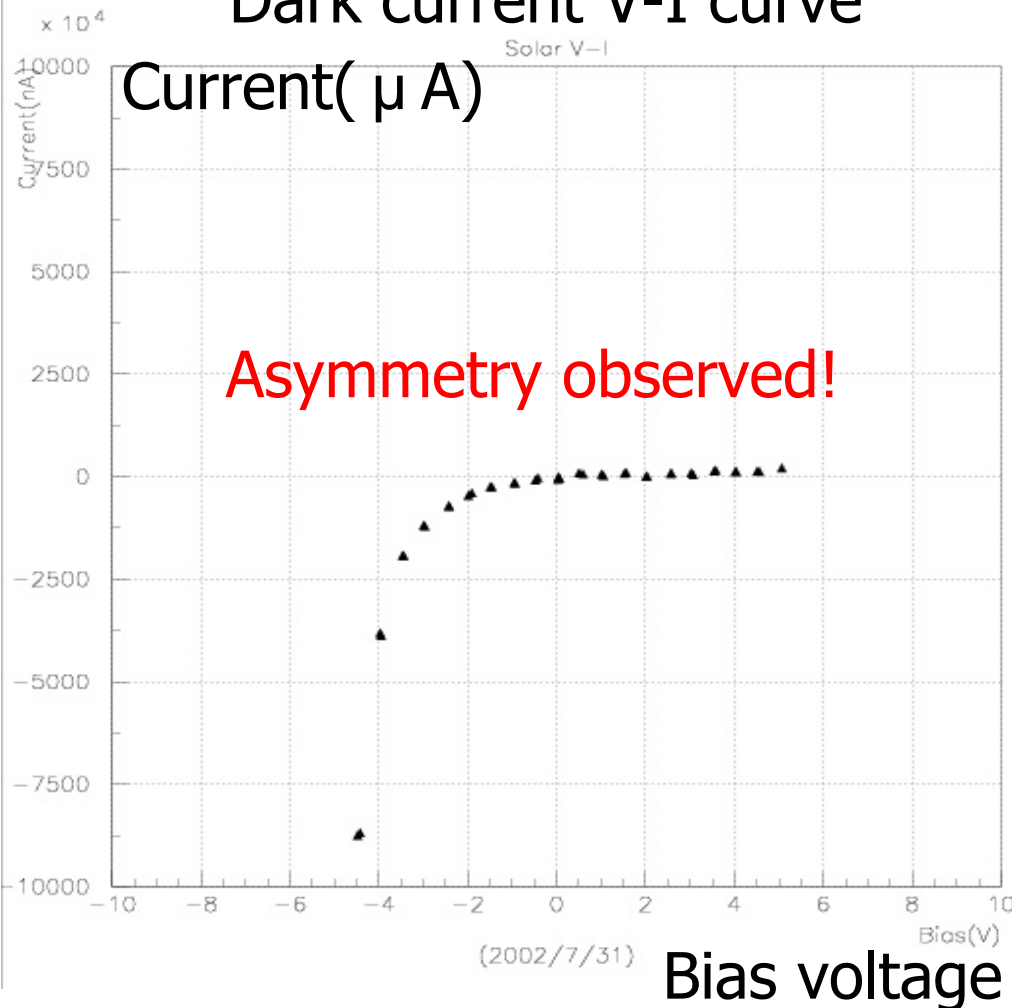


# Current setting

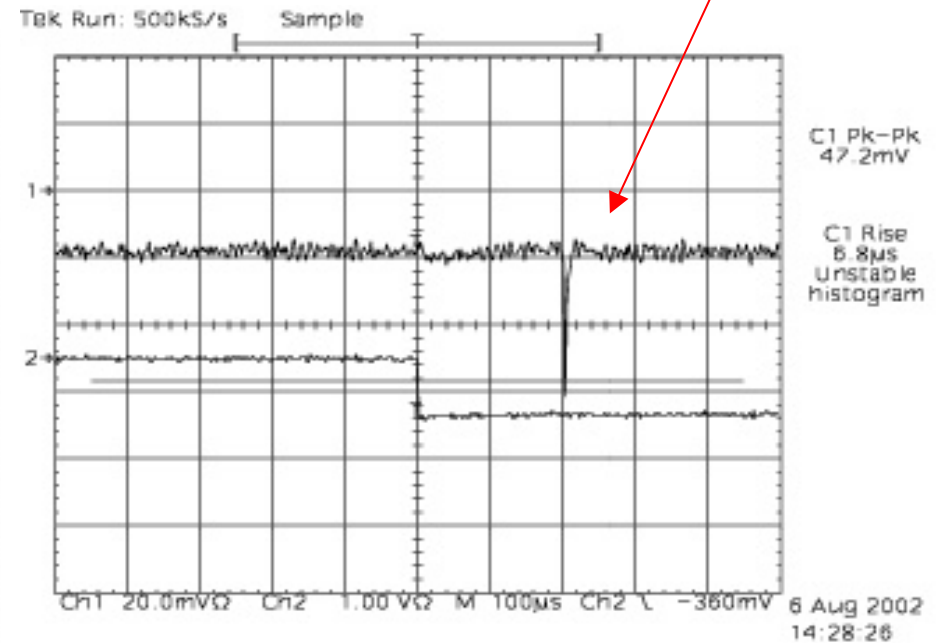


# Solar panel bench test

Dark current V-I curve



Laser signal observed!



Laser pulse signal  
Wave length : 532nm  
Bias voltage : 5.0V





# Schedule

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- Beam test setting
  - PMT Holder already ordered
  - Order tiles and acryl (after getting scintillator)  
early September we want to get
  - Finish to order all materials we need
- Bench test
  - Find the causes of mapping result, then redo mapping test  
(retake using old setting)
  - Continue to find two P.E. peak